

1.0 Scope.

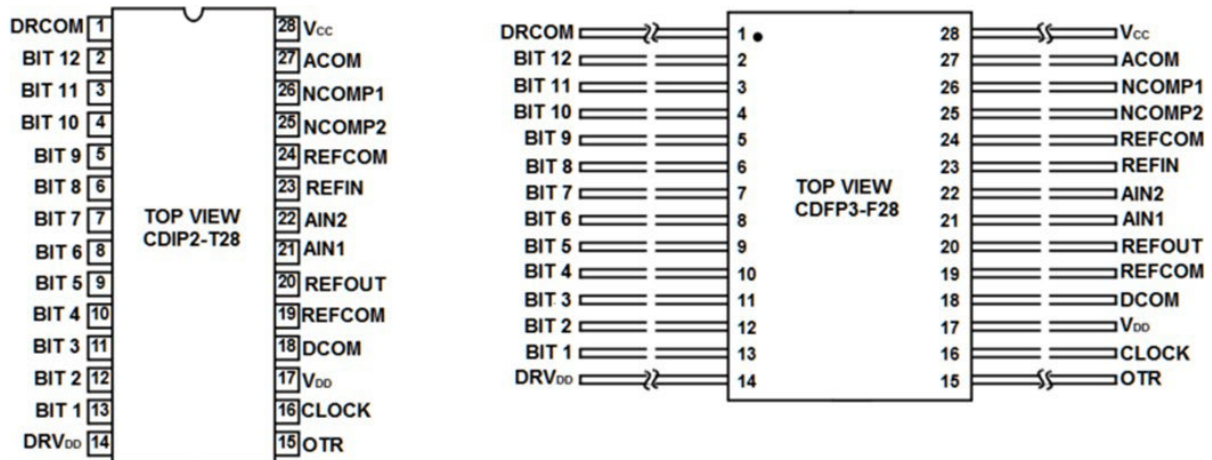
This specification documents the detail requirements for space qualified product manufactured on Analog Devices, Inc.'s QML certified line per MIL-PRF-38535 Level V except as modified herein. The manufacturing flow described in the STANDARD SPACE LEVEL PRODUCTS PROGRAM brochure is to be considered a part of this specification. This brochure may be found at: <http://www.analog.com/aerospace>. This data sheet specifically details the space grade version of this product. A more detailed operational description and a complete data sheet for commercial product grades can be found at www.analog.com/AD1672.

2.0 Part Number: The complete part number(s) of this specification follow:

Part Number	Description
AD1672-703F	12-Bit, 3 MSPS, A to D Converter
AD1672-713D	12-Bit, 3 MSPS, A to D Converter with radiation test

2.1 Case Outline:

Letter	Descriptive designator	Case Outline (Lead Finish per MIL-PRF-38535)
D	CDIP2-T28	28-Lead Side-brazed DIP package
F	CDFP3-F28	28-Lead bottom-brazed flatpack



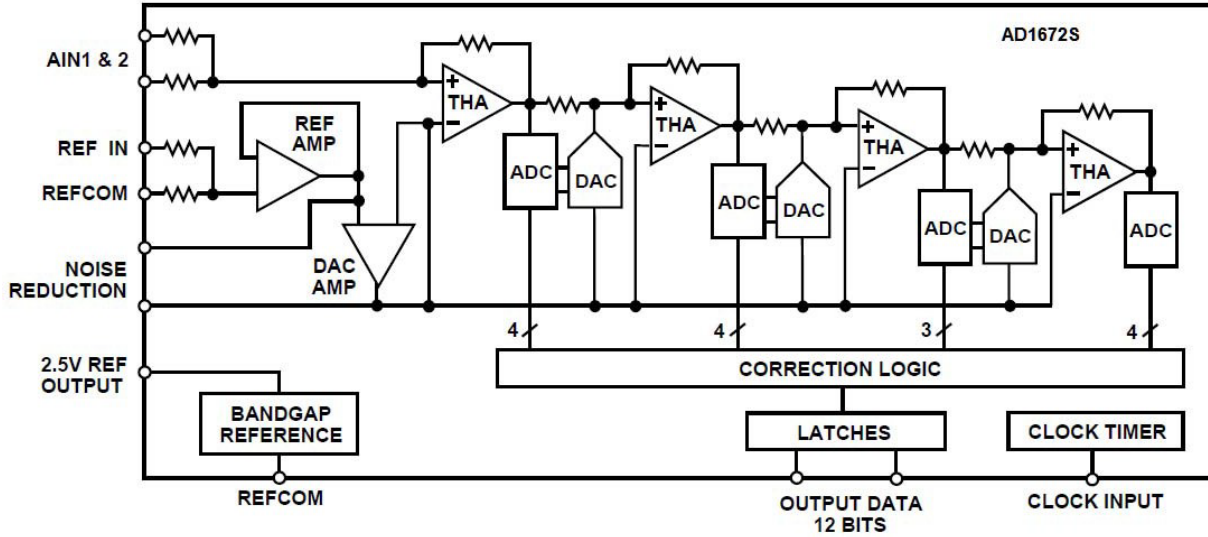
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AD1672S

FUNCTIONAL BLOCK DIAGRAM



PIN DESCRIPTION

Symbol	Pin No.	Type	Name and Function
DRCOM	1	P	Digital Output Drive Ground
BIT 12	2	DO	Data Bit (LSB).
Bit 2-11	3-12	DO	Data Bits
BIT 1	13	DO	Data Bit (MSB).
DRV _{DD}	14	P	+5V Digital Output Drive Supply (3.0V to 5.25V)
OTR	15	DO	Out of Range is Active High on the leading edge of Code 0 or the trailing edge of Code 4096.
CLOCK	16	DI	Sample Clock
V _{DD}	17	P	+5V Digital Supply
DCOM	18	P	Digital Ground
REFCOM	19, 24	P	Analog Ground
REFOUT	20	AO	2.5V Reference Output (Decouple with 1μF ceramic capacitor to REFCOM).
AIN1	21	AI	Analog Input
AIN2	22	AI	Analog Input
REFIN	23	AI	Reference Input
NCOMP2	25	AO	Noise Compensation (Decouple with 1μF ceramic capacitor to ACOM).
NCOMP1	26	AO	Noise Compensation (Decouple with 1μF ceramic capacitor to ACOM).
ACOM	27	P	Analog Ground
V _{CC}	28	P	+5V Analog Supply

TYPE: AI = Analog Input; DI = Digital Input; P = Power
 AO = Analog Output; DO = Digital Output

Figure 1 - Terminal connections.

3.0 Absolute Maximum Ratings. (TA = 25°C, unless otherwise noted)

V _{CC} with respect to ACOM	to +6.5V
V _{DD} with respect to DCOM	to +6.5V
DRV _{DD} with respect to DRCOM	to +6.5V
ACOM with respect to DCOM, DRCOM	to +0.5V
Clock with respect to DCOM.....	to V _{DD} + 0.5V
Digital Outputs with respect to DCOM.....	V to DRV _{DD} + 0.5V
AIN with respect to ACOM	V to +6.5V
REFIN with respect to ACOM.....	V to V _{CC} + 0.5V
Junction Temperature (T _J)	+150°C
Operating Temperature Range	-55°C to + 125°C
Storage Temperature.....	-65°C to +150°C
Lead Temperature (10 sec)	+300°C

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specification is not implied. Exposure to absolute maximum ratings for extended periods may effect device reliability.

3.1 Thermal Characteristics:

Thermal Resistance, Side-brazed (D) Package

Junction-to-Case (Θ_{JC}) = 28°C/W Max

Junction-to-Ambient (Θ_{JA}) = 70°C/W Max

Thermal Resistance, Bottom brazed (F) Package

Junction-to-Case (Θ_{JC}) = 22°C/W Max

Junction-to-Ambient (Θ_{JA}) = 60°C/W Max

4.0 Electrical Table:

Table I						
Parameter (see notes at end of table)	Symbol	Conditions 1/ Unless Otherwise Specified	Sub Group	Limit Min	Limit Max	Units
Resolution		No Missing Codes	1,2,3	12		Bits
Supply Current	I _{VCC} I _{VDD} I _{DRVDD}		1,2,3		65 2 2	mA
Power Dissipation	PD		1,2,3		363	mW
Power supply rejection 3/	PSR	V _{CC} = 5.0V ± 0.25V V _{DD} = 5.0V ± 0.25V V _{DRVDD} = 3.0V to 5.25V	1,2,3	-0.3 -0.3 -0.1	0.3 0.3 0.1	%FSR
ACCURACY			1,2,3			
Integral Nonlinearity 7/	INL			-2.5	2.5	LSB
Differential Nonlinearity 7/	DNL			-1	1.5	LSB
Offset Zero	VOSE			-0.75	0.75	%FSR
Zero Error 5/				-0.75	0.75	%FSR
Gain Error 2/				-1.5	1.5	%FSR
Internal Voltage Reference 6/	V _o	I _{OUT} = 0.5 mA 4/	1,2,3	2.475	2.525	V

AD1672S

4.0 Electrical Table: (Cont'd)

Parameter See notes at end of table	Symbol	Conditions ^{1/} Unless Otherwise Specified	Sub Group	Limit Min.	Limit Max	Units
Analog Input		2.5V Range Unipolar 5.0V Range Unipolar 5.0V Bipolar	1,2,3	0 0 -2.5	2.5 5 2.5	V
Input Resistance		2.5V Input Range 5.0V Input Range	1,2,3	1.5 3	2.5 5	K Ω
Output Voltage, High	V _{OH}	I _{OH} = 0.5 mA	1,2,3	2.4		V
Output Voltage, Low	V _{OL}	I _{OL} = 1.6 mA	1,2,3		0.4	V
Logic Inputs Logic "0" Input Current Logic "1" Input Current	I _{IH} I _{IL}	V _{IH} =V _{DD} V _{IL} =0V	1,2,3	-10	10	μ A
AC Parameters:						
Parameter See notes at end of table	Symbol	Conditions ^{1/} Unless Otherwise Specified	Sub Group	Limit Min.	Limit Max	Units
Signal to Noise Distortion	SINAD	f _{input} =500KHz	4 5 6	63 59 62		dB
Signal to Noise Ratio	SNR	f _{input} =500KHz	4 5 6	66 59 62		dB
Total Harmonic Distortion	THD	f _{input} =500KHz	4,5,6	-64		dB
Spurious Free Dynamic Range	SFDR	f _{input} =500KHz	4,5,6	-65		dB

NOTES:

^{1/} V_{CC} = V_{DD} = V_{DRVDD} = +5.0V.

^{2/} Includes internal reference error.

^{3/} Change in full scale as a function of the dc supply voltage.

^{4/} Current available for external loads. External load should not change during conversion.

^{5/} Bipolar Mode

^{6/} The AD1672 includes an onboard +2.5 V reference. The reference input pin (REF IN) can be connected to reference output pin (REF OUT) or a standard external +2.5 V reference can be selected to meet specific system requirements. The reference input voltage can be held with the use of a capacitor. To prevent the AD1672's onboard reference from oscillating when not connected to REF IN, REF OUT must be connected to +5 VVCC. It is possible to connect REF OUT to +5 V due to its output circuit implementation which shuts down the reference

^{7/} This parameter is not tested post-irradiation.

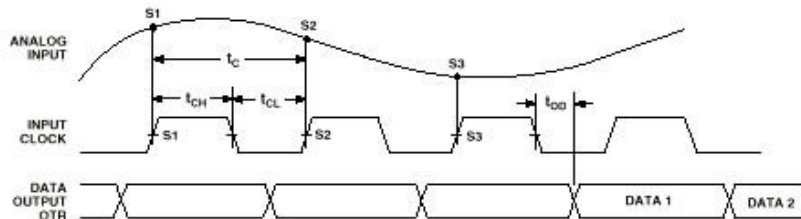


Figure 1. Timing Diagram

SWITCHING SPECIFICATIONS

Parameter	Symbol	Value	Units
Clock Period	t _C	334	ns min
Clock			
Pulse Width High	t _{CH}	167	ns min
Pulse Width Low	t _{CL}	167	ns min
Output Delay	t _{OD}	15	ns min
		30	ns typ
Pipeline Delay (Latency)		2.5	Clock Cycles

4.1 **Electrical Test Requirements:**

Table II	
Test Requirements	Subgroups (in accordance with MIL-PRF-38535, Table III)
Interim Electrical Parameters	1
Final Electrical Parameters	1, 2, 3, 4, 5, 6 <u>1/2/</u>
Group A Test Requirements	1, 2, 3, 4, 5, 6
Group C end-point electrical parameters	1 <u>2/</u>
Group D end-point electrical parameters	1
Group E end-point electrical parameters	1

Table II Notes

1/ PDA applies to Subgroup 1 only. No other subgroups are included in PDA.

2/ See table III for delta parameters.

4.2 **Table III. Life Test/Burn-In test delta limits.**

Table III			
TEST TITLE	ENDPOINT LIMIT	DELTA LIMIT	UNITS
I _{CC}	65	±6.5	mA
V _{OH}	2.4	±0.24	V
V _{OL}	0.4	±0.1	V

5.0 **Test/Burn-In Circuit:**

- 5.1 HTRB is not applicable for this drawing.
- 5.2 Burn-in is per MIL-STD-883 Method 1015 test condition D.
- 5.3 Steady state life test is per MIL-STD-883 Method 1005.

AD1672S

Rev	Description of Change	Date
A	Initiate	4/20/2000
B	Add Flatpack, Add radiation part number, Add timing information on page 3.	3/22/2001
C	Update web address.	2/7/2002
D	Change subgroups 4, 5, 6 to 9, 10, 11. Update web address	1/9/2003
E	Delete Burn-In circuit.	8/5/2003
F	Update header/footer and add to 1.0 Scope description	2/19/2008
G	Add Operating Temperature Range to Section 3.0 & Remove (See Figure 2) in Sections 5.2 and 5.3	4/4/2008
H	Remove obsolete part numbers and update ASD to ADI Standard	11/30/2011
I	Corrected typo in section 4.0 Electrical Table.	11/08/2013
J	Add application note to prevent oscillation	01/18/2015
K	Simplify ICC Delta limit by listing absolute value vs % of specification. No change in limit	07/13/2016
L	Corrected copyright date	07/29/2016
M	Corrected font errors in last release	8/23/2016
N	Corrected typo in section 4.0 Electrical Table 1	11/1/2016
O	Change S(N+D) to SINAD, SNR and SINAD limit Change for Subgroup 5, Change to ADI Standard V_{DRDD} to V_{DRVDD} of Power Supply Rejection, All Subgroup 4,5,6 not 9,10,11, Add DRV_{DD} voltage range at Pin Description page.	10/06/2017
P	Corrected typo on DIP package designator to CDIP2-T28. Include Pin-outs and Functional Block Diagram.	1/23/2019
Q	Added footnote 7/ to indicate test parameters are not tested post-irradiation.	2/02/2026